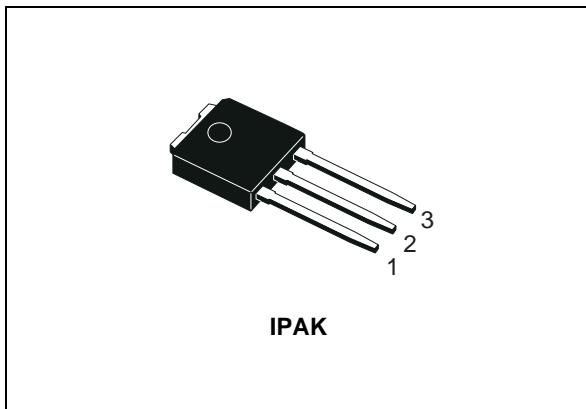
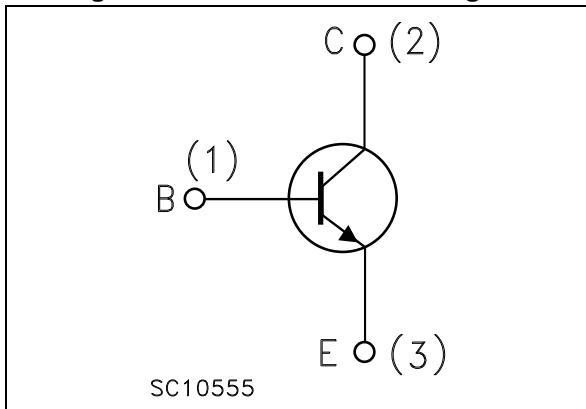


## High voltage fast-switching NPN power transistor

Datasheet - production data



**Figure 1. Internal schematic diagram**



### Features

- High voltage capability
- Low spread of dynamic parameters
- Very high switching speed

### Application

- Switch mode power supplies (AC-DC converters)

### Description

This device is manufactured using high voltage multi epitaxial planar technology for high switching speeds and high voltage capability. It uses a cellular emitter structure with planar edge termination to enhance switching speeds while maintaining a wide RBSOA.

**Table 1. Device summary**

Order code	Marking	Package	Packaging
STU13005N	U13005N	IPAK	Tube

## Contents

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# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{CES}$	Collector-emitter voltage ( $V_{BE} = 0$ )	700	V
$V_{CEO}$	Collector-emitter voltage ( $I_B = 0$ )	400	V
$V_{EBO}$	Emitter-base voltage ( $I_C = 0$ ; $I_B = 1.5$ A; $t_p < 10$ ms)	$V_{(BR)EBO}$	V
$I_C$	Collector current	3	A
$I_{CM}$	Collector peak current ( $t_p < 5$ ms)	6	A
$I_B$	Base current	1.5	A
$I_{BM}$	Base peak current ( $t_p < 5$ ms)	3	A
$P_{TOT}$	Total dissipation at $T_c = 25$ °C	30	W
$T_{STG}$	Storage temperature	-65 to 150	°C
$T_J$	Max. operating junction temperature	150	°C

**Table 3. Thermal data**

Symbol	Parameter	Value	Unit
$R_{thJC}$	Thermal resistance junction-case max	4.2	°C/W

## 2 Electrical characteristics

$T_{case} = 25^\circ\text{C}$  unless otherwise specified.

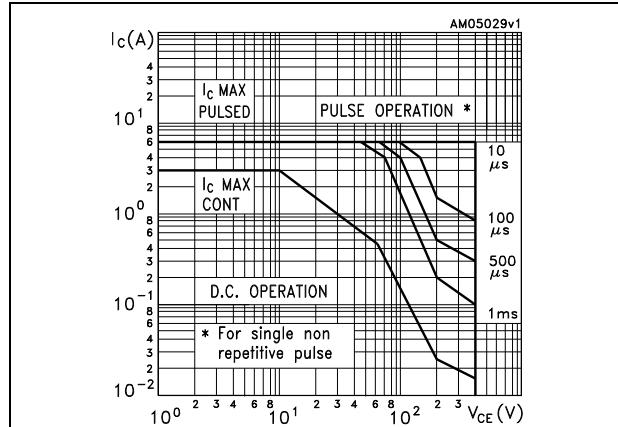
**Table 4. Electrical characteristics**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{CES}$	Collector cut-off current ( $V_{BE} = 0$ )	$V_{CE} = 700 \text{ V}$ $V_{CE} = 700 \text{ V} \quad T_C = 125^\circ\text{C}$			1 5	mA mA
$I_{CEO}$	Collector-cut-off current ( $I_B = 0$ )	$V_{CE} = 400 \text{ V}$			1	mA
$V_{(BR)EBO}$	Emitter base breakdown voltage ( $I_C = 0$ )	$I_E = 10 \text{ mA}$	9		18	V
$V_{CEO(sus)}^{(1)}$	Collector-emitter sustaining voltage ( $I_B = 0$ )	$I_C = 10 \text{ mA}$	400			V
$V_{CE(\text{sat})}^{(1)}$	Collector-emitter saturation voltage	$I_C = 1 \text{ A} \quad I_B = 200 \text{ mA}$			0.5	V
		$I_C = 2 \text{ A} \quad I_B = 500 \text{ mA}$			0.6	V
		$I_C = 3 \text{ A} \quad I_B = 750 \text{ mA}$			5	V
$V_{BE(\text{sat})}^{(1)}$	Base-emitter saturation voltage	$I_C = 1 \text{ A} \quad I_B = 200 \text{ mA}$			1.2	V
		$I_C = 2 \text{ A} \quad I_B = 500 \text{ mA}$			1.6	V
$h_{FE}^{(1)}$	DC current gain	$I_C = 500 \mu\text{A} \quad V_{CE} = 2 \text{ V}$	15			
		$I_C = 425 \text{ mA} \quad V_{CE} = 2 \text{ V}$	24			
		$I_C = 1 \text{ A} \quad V_{CE} = 5 \text{ V}$	10		30	
		$I_C = 2 \text{ A} \quad V_{CE} = 5 \text{ V}$	8		24	
$t_s$ $t_f$	Resistive load Storage time Fall time	$I_C = 2 \text{ A} \quad V_{CC} = 125 \text{ V}$ $I_{B1} = -I_{B2} = 400 \text{ mA}$ $t_p = 30 \mu\text{s}$		1.65 260		$\mu\text{s}$ $\text{ns}$
$t_s$ $t_f$	Inductive load Storage time Fall time	$I_C = 1 \text{ A} \quad V_{clamp} = 300 \text{ V}$ $I_{B1} = 200 \text{ mA} \quad V_{BE(off)} = -5 \text{ V}$ $L = 50 \text{ mH} \quad R_{BB} = 0$		0.8 150		$\mu\text{s}$ $\text{ns}$

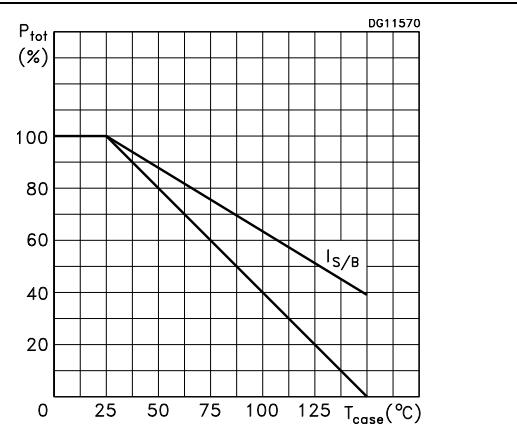
1. Pulse test: pulse duration  $\leq 300 \mu\text{s}$ , duty cycle  $\leq 2\%$

## 2.1 Electrical characteristics (curves)

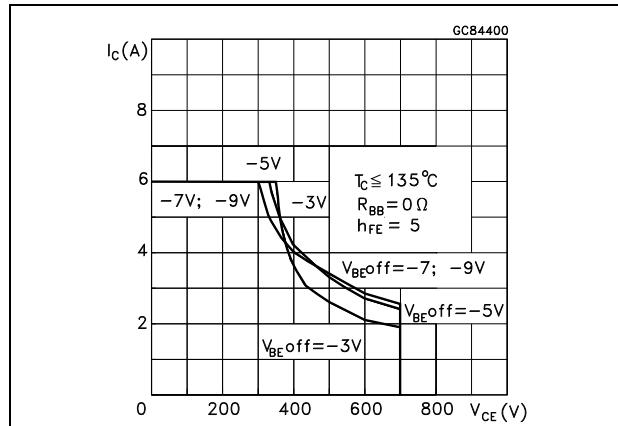
**Figure 2. Safe operating area**



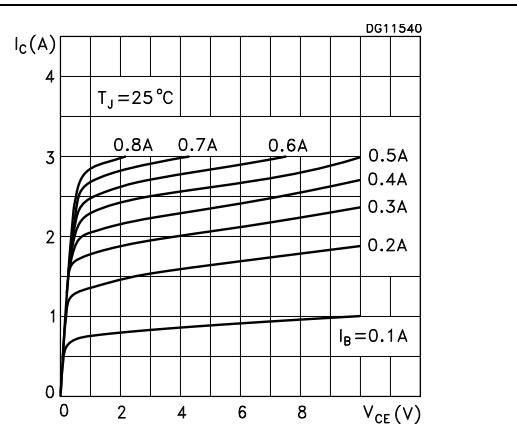
**Figure 3. Derating curve**



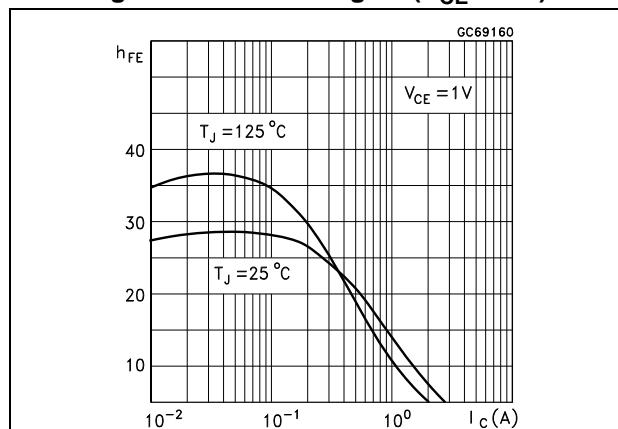
**Figure 4. Reverse biased SOA**



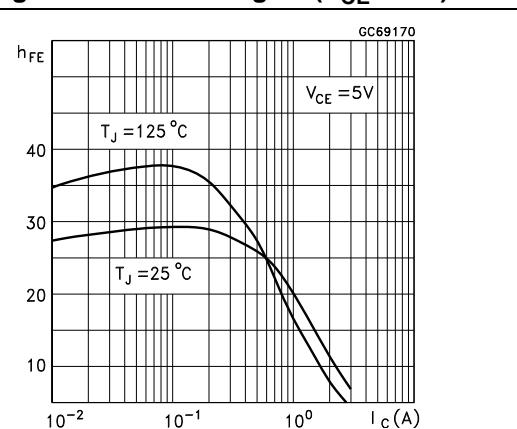
**Figure 5. Output characteristics**

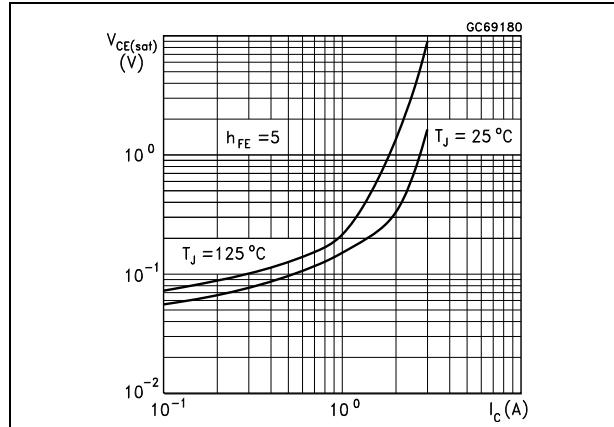
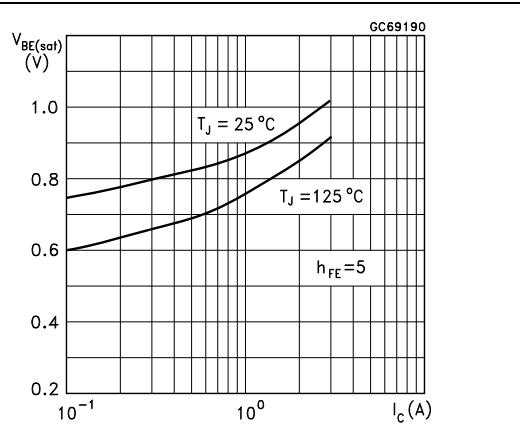
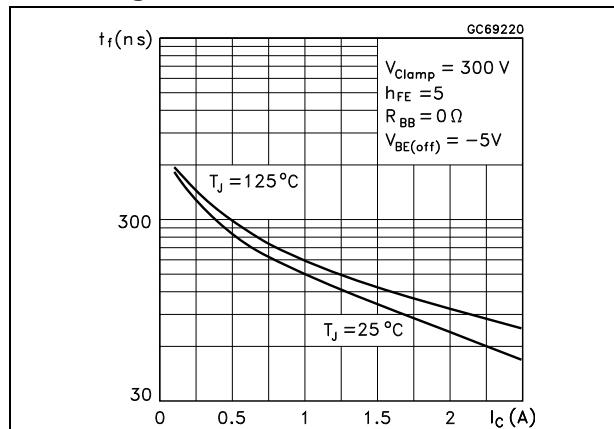
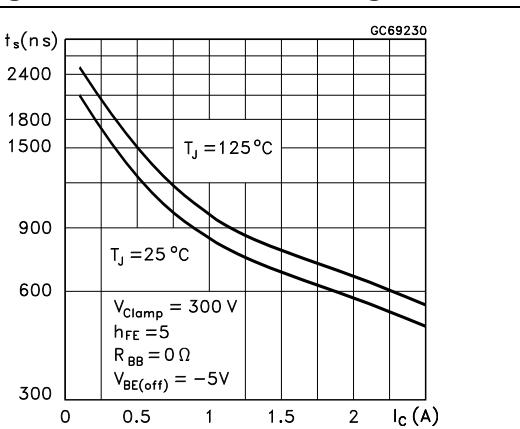
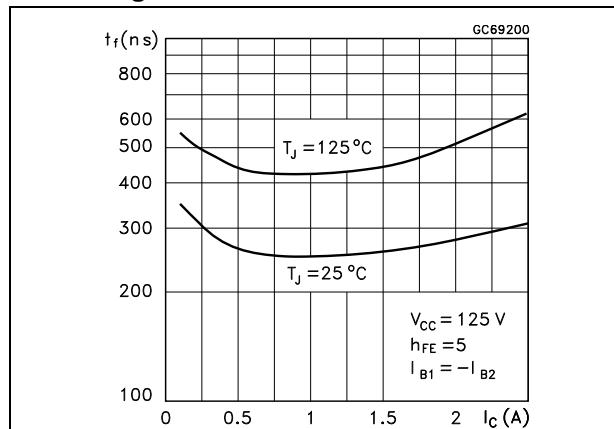
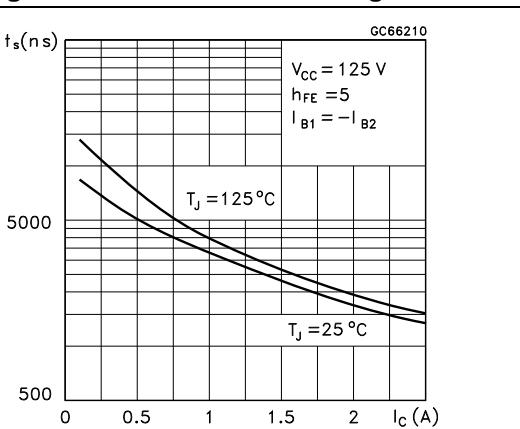


**Figure 6. DC current gain ( $V_{CE} = 1$  V)**



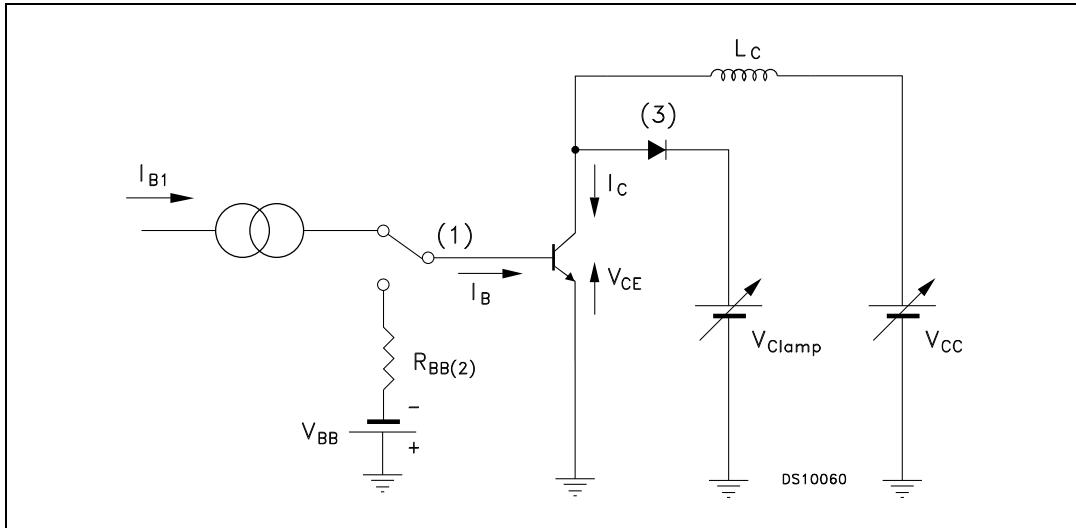
**Figure 7. DC current gain ( $V_{CE} = 5$  V)**



**Figure 8. Collector-emitter saturation voltage****Figure 9. Base-emitter saturation voltage****Figure 10. Inductive load fall time****Figure 11. Inductive load storage time****Figure 12. Resistive load fall time****Figure 13. Resistive load storage time**

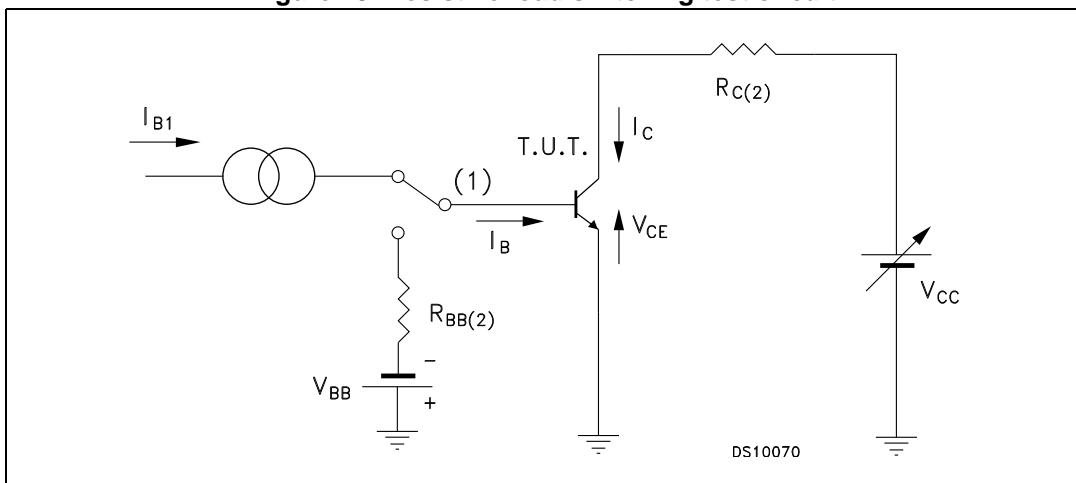
### 3 Test circuits

**Figure 14. Inductive load switching test circuit**



- 1) Fast electronic switch
- 2) Non-inductive resistor
- 3) Fast recovery rectifier

**Figure 15. Resistive load switching test circuit**

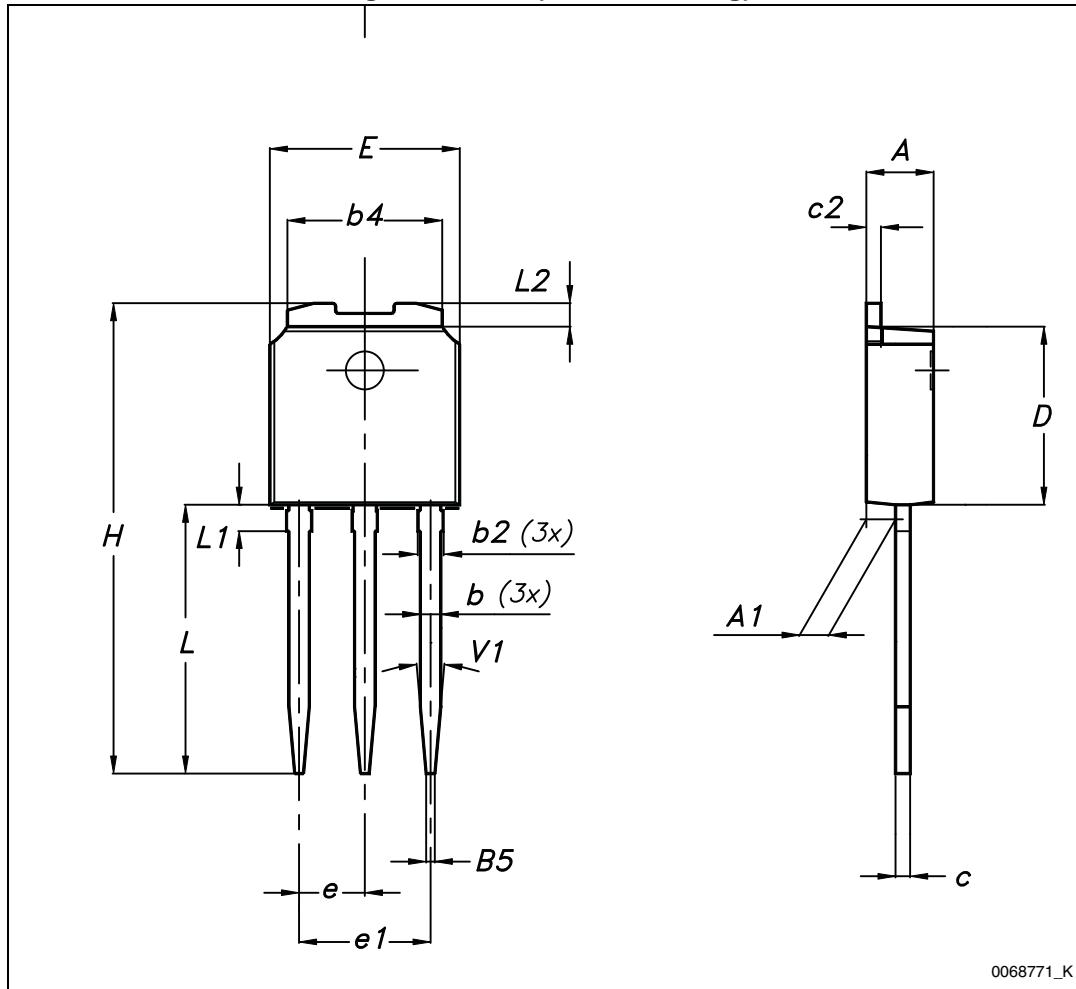


- 1) Fast electronic switch
- 2) Non-inductive resistor

## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com).  
ECOPACK® is an ST trademark.

Figure 16. IPAK(TO-251 drawing)



**Table 5. IPAK (TO-251) mechanical data**

DIM	mm.		
	min.	typ.	max.
A	2.20		2.40
A1	0.90		1.10
b	0.64		0.90
b2			0.95
b4	5.20		5.40
B5		0.30	
c	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
E	6.40		6.60
e		2.28	
e1	4.40		4.60
H		16.10	
L	9.00		9.40
L1	0.80		1.20
L2		0.80	1.00
V1		10°	

## 5 Revision history

**Table 6. Document revision history**

Date	Revision	Changes
20-Feb-2012	1	First release.
09-May-2014	2	Updated <a href="#">Table 1: Device summary</a> and updated <a href="#">Figure 4: Package mechanical data</a>